

Silicon N-Channel Junction FET

Description

The 2SK125 is an N-Channel silicon junction type field effect transistor developed for low-noise amplification at frequencies up to UHF. It is especially suitable for when a wide dynamic range is required.

Features

- High power gain
12.5 dB (Typ.)
(f = 100 MHz Gate grounded)
- Low noise figure
1.5 dB (Typ.)
(f = 100 MHz Gate grounded)
- Wide dynamic range
3rd intermodulation distortion
- 52 dB (Typ.)
(f = 100 MHz at 100 dB μ input)
- Small inverse transfer coefficient
 $|S_{12}| = 0.035$ (Typ.)
(f = 500 MHz Gate grounded)

Structure

Silicon N-Channel junction FET.

Application

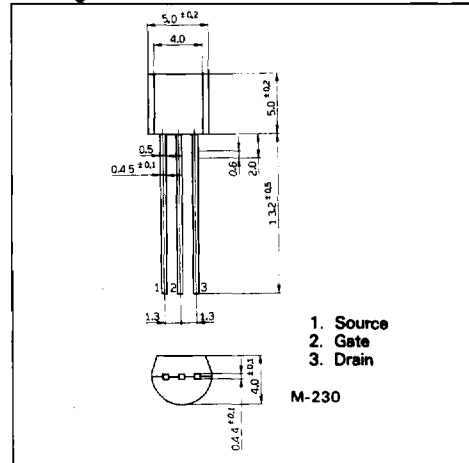
UHF band amplification, mixing, oscillation, analog switches.

Absolute Maximum Ratings (Ta = 25°C)

| | | | |
|-------------------------------|------|---------------|----|
| • Drain to gate voltage | VDGO | 35 | V |
| • Source to gate voltage | VSGO | 35 | V |
| • Drain current | ID | 100 | mA |
| • Gate current | IG | 10 | mA |
| • Channel temperature | Tj | 120 | °C |
| • Storage temperature | Tstg | - 50 to + 120 | °C |
| • Allowable power dissipation | PD | 300 | mW |

Package Outline

Unit: mm



Electrical Characteristics

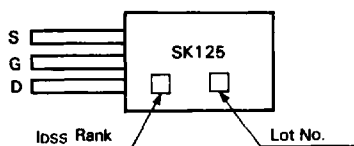
Ta = 25°C

| Item | Symbol | Condition | Min. | Typ. | Max. | Unit | |
|--|----------|--|------|------|------|------|----|
| Gate cutoff current | IGSS | VGS = -15V, VDS = 0 | | | -10 | nA | |
| Gate to source voltage | VGSS | IG = 10μA, VDS = 0 | -35 | | | V | |
| Drain current | IDSS | VDS = 10V, VGS = 0 P.W = 300μs | 40 | | 75 | mA | |
| Gate to source cutoff voltage | VGS(OFF) | VDS = 10V, ID = 100μA | -2 | | -6 | V | |
| Forward transfer conductance | Yfs | VDS = 10V, ID = 10mA f = 1 kHz | 10 | 14 | | mS | |
| Reverse transfer capacitance | Crss | VDS = 10V, IS = 0mA f = 1 MHz, source grounded | | 2.6 | 3 | pF | |
| Power gain | PG | VDS = 10V, ID = 10mA f = 100 MHz, BW = 2.8 MHz | *1 | 10 | 12.5 | dB | |
| Noise figure | NF | VDS = 10V, ID = 10mA f = 100 MHz, BW = 2.8 MHz At the NF of the amplifier in the next stage is 4.2 dB | *1 | | 1.8 | 2.5 | dB |
| Intermodulation distortion | IMD | VDS = 10V, ID = 10mA, f1 = 100 MHz, f2 = 100.1 MHz, at 100 dBμ input | *2 | -45 | -52 | dB | |
| Junction to ambient thermal resistance | θj-a | | | | 190 | °C/W | |

Note) *1. See the 100 MHz, PG, NF, test circuit.

*2. See the 100 MHz IMD test circuit.

Mark



Classification

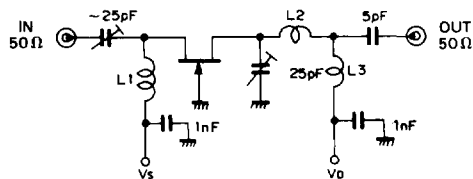
| Rank | I _{DSS} (mA) V _{DS} = 10V V _{GS} = 0V |
|------|--|
| 2 | 40 to 75 |
| 3 | 40 to 52 |
| 4 | 48 to 63 |
| 5 | 57 to 75 |

Standard Circuit Design Data

Ta = 25°C

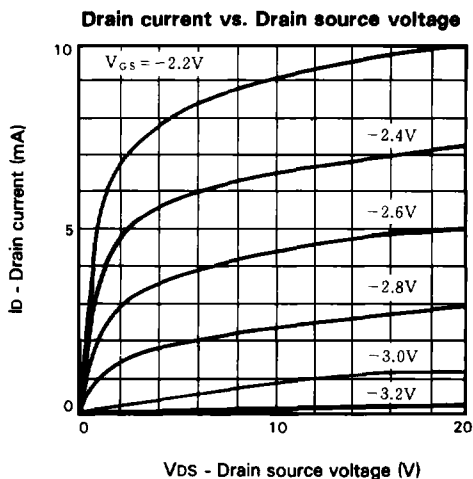
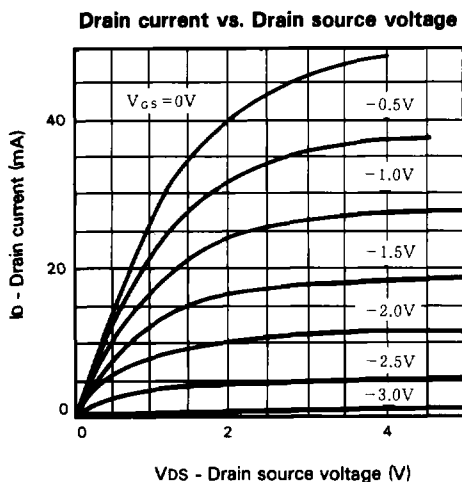
| Item | Symbol | Condition | Typ. | Unit |
|--------------------------------|--------------|--|-------|------------------------|
| Input resistance | r_{ig} | $V_{DG} = 10V, I_D = 10\text{ mA}$ $f = 100\text{ MHz}$ | 70 | Ω |
| Input capacitance | C_{ig} | | 3.0 | pF |
| Output resistance | r_{og} | | 5 | k Ω |
| Output capacitance | C_{og} | | 3.0 | pF |
| Power gain | PG | $V_{DG} = 10V, I_D = 10\text{ mA}$ $f = 500\text{ MHz}, BW = 12\text{ MHz}$ | 7.0 | dB |
| Noise figure | NF | | 4.0 | dB |
| Reverse transfer coefficient | $ S_{12} $ | $V_{DG} = 10V, I_D = 10\text{ mA}$ $f = 500\text{ MHz}$ | 0.035 | |
| Equivalent input noise voltage | \bar{e}_n | $V_{DS} = 10V, I_D = 10\text{ mA}$ $f = 1\text{ kHz}$ | 3 | nV/ $\sqrt{\text{Hz}}$ |
| Drain source ON resistance | R(ON) | $I_D = 10\text{ mA}, V_{GS} = 0V$ | 35 | Ω |
| Drain cutoff current | $I_{D(OFF)}$ | $V_{DS} = 10V, V_{GS} = -10V$ | 0.1 | nA |

100 MHz PG, NF Test Circuit

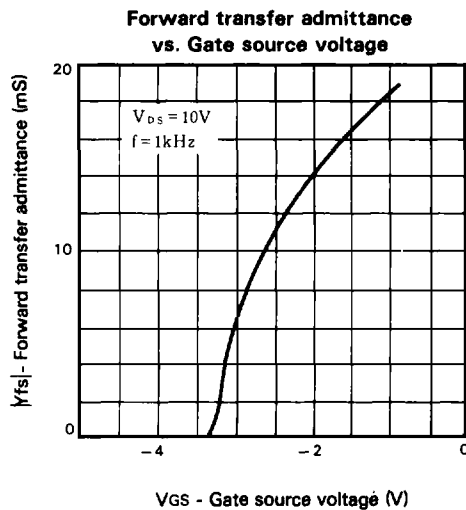
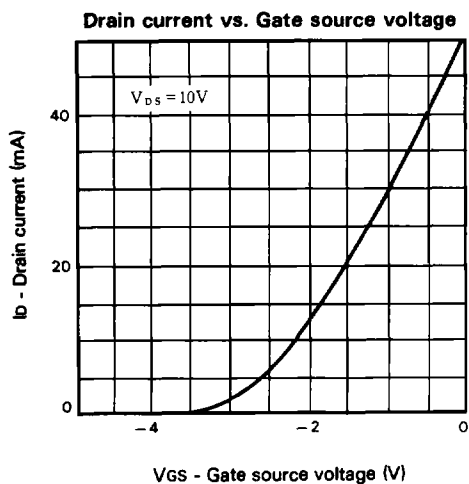


- L1 : 0.45 φmm polyurethane wire φ3 mm 10.5 t
- L2, L3 : 0.45 φmm polyurethane wire φ3 mm 5.5 t

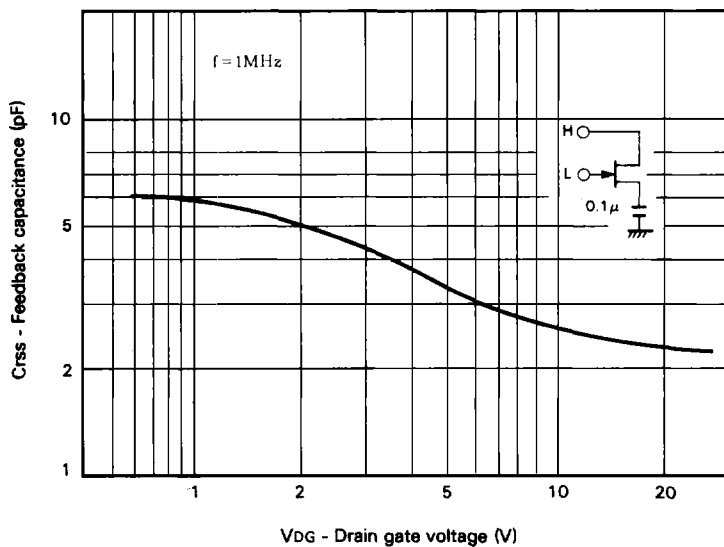
Output Characteristics



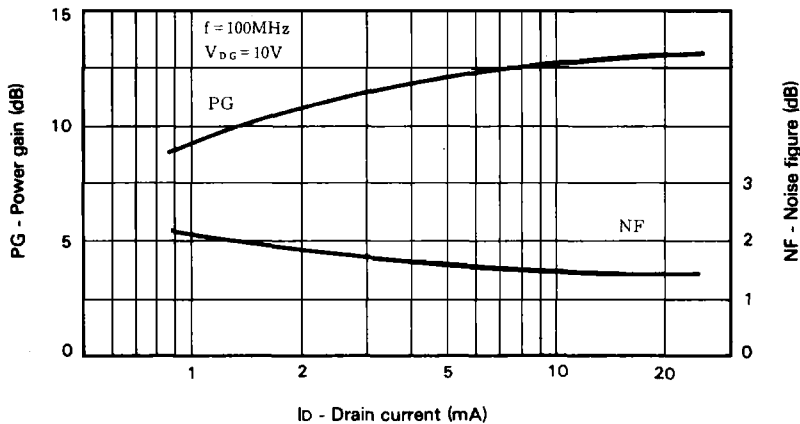
Transfer Characteristics



Feedback capacitance vs. Drain gate voltage

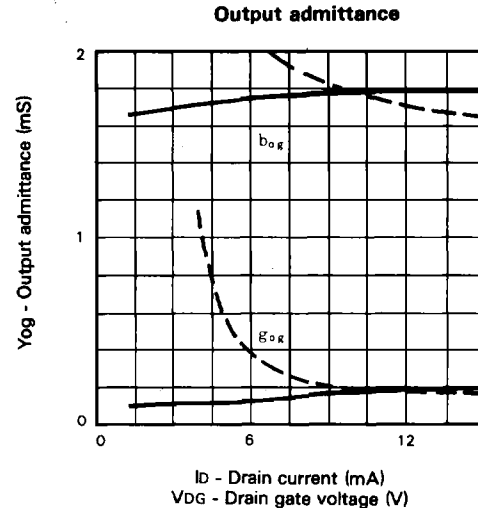
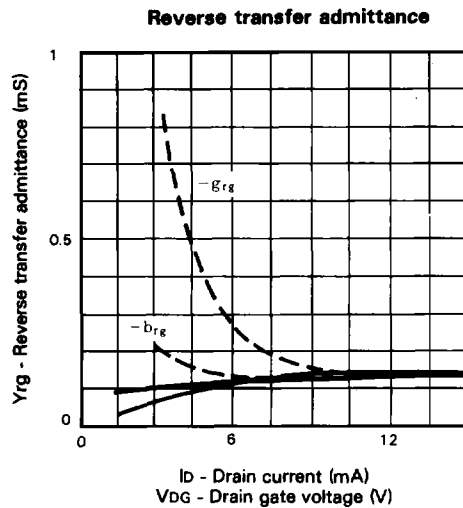
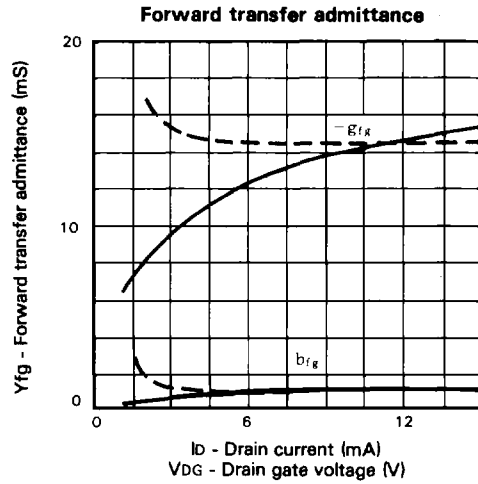
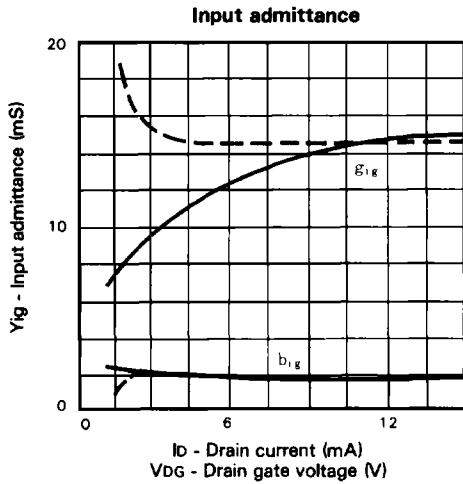


Common-gate power gain noise figure vs. Drain current

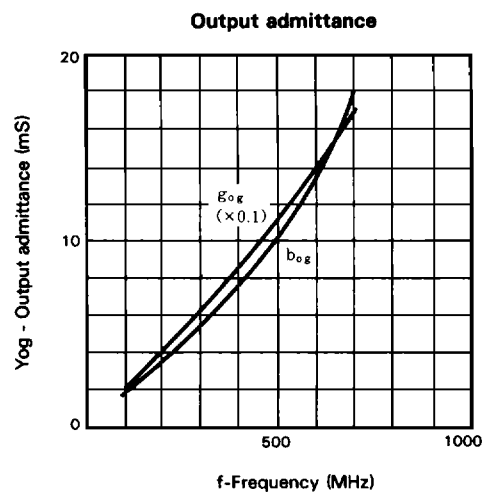
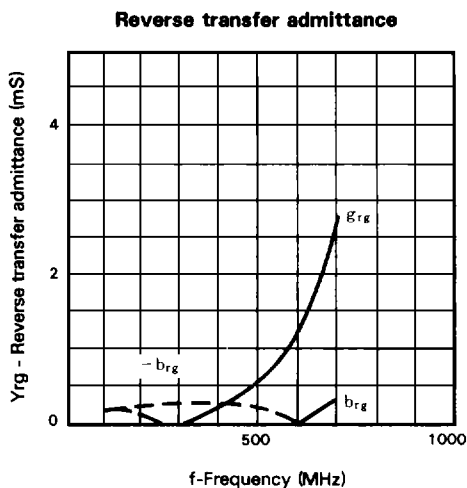
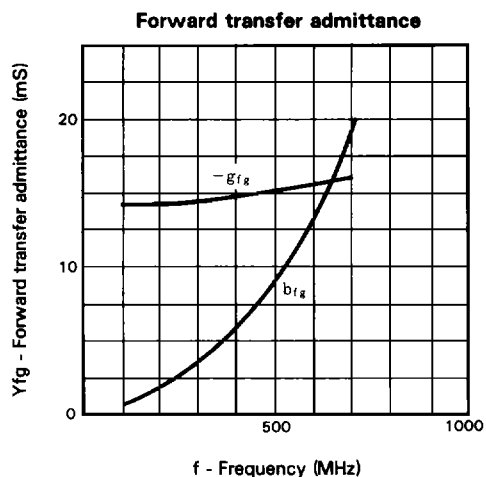
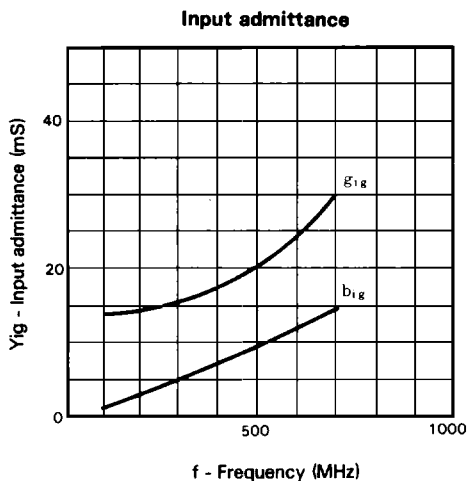


Common Gate Y-Parameter

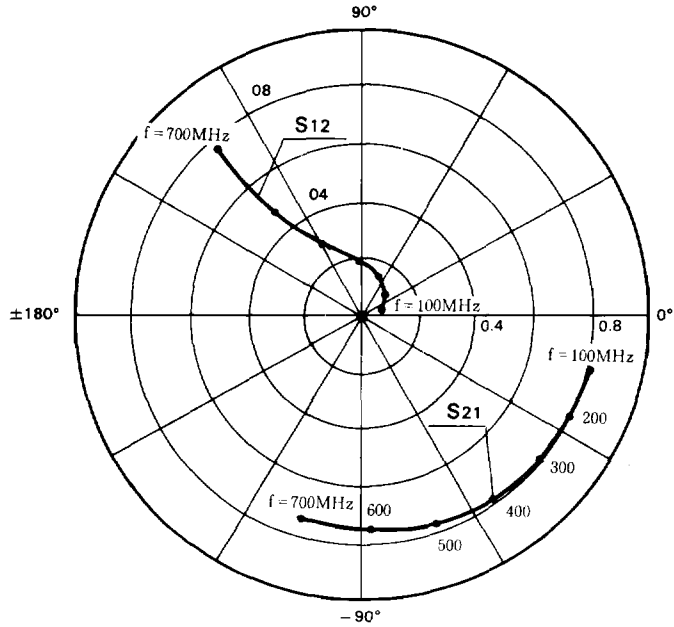
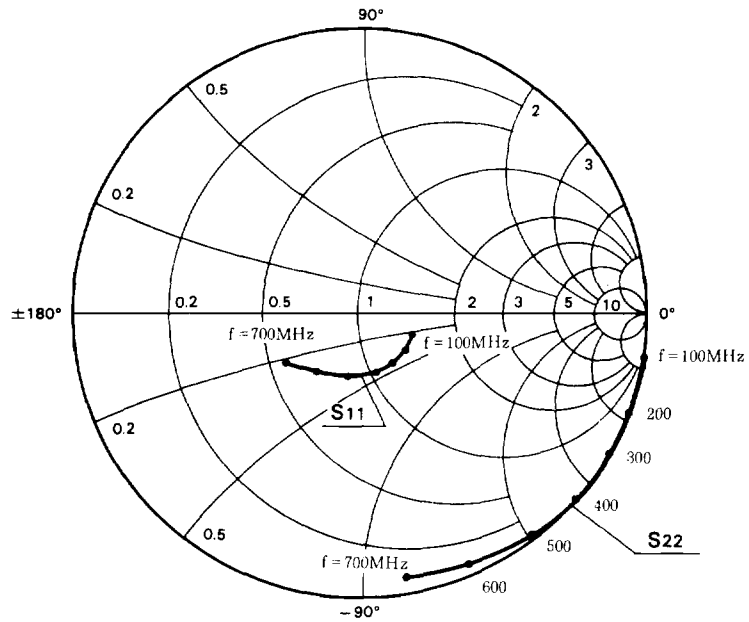
- Drain current characteristics ($V_{DG} = 10V, f = 100\text{ MHz}$)
- - - Drain gate voltage characteristics ($I_D = 10\text{ mA}, f = 100\text{ MHz}$)



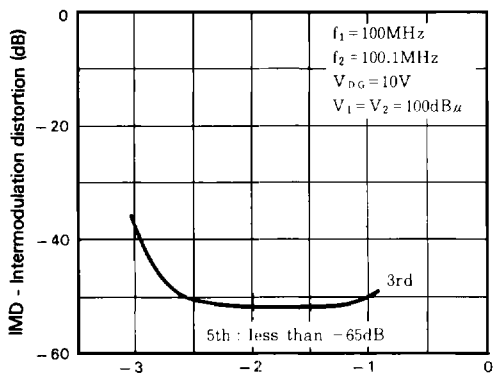
Common Gate Y-Parameter vs. Frequency ($V_{DG} = 10V, I_D = 10mA$)



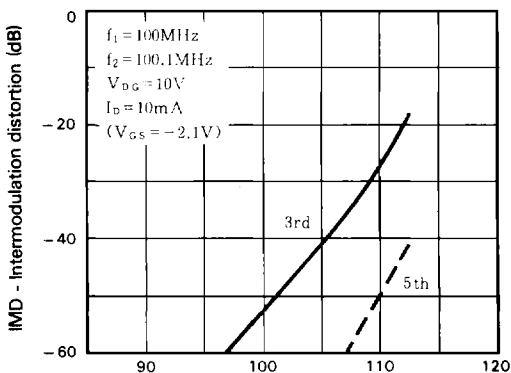
Common Gate S-Parameter vs. Frequency ($V_{DG} = 10V, I_D = 10\text{ mA}$)



Intermodulation distortion characteristics

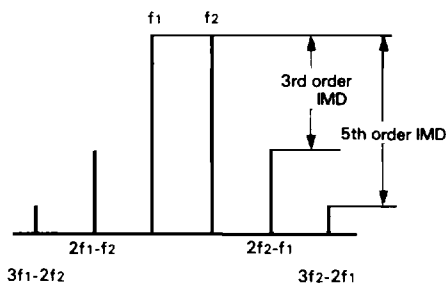
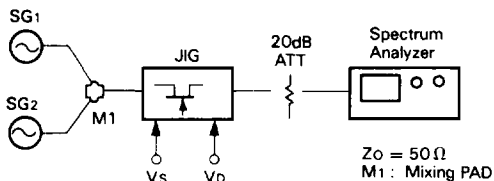


VGS - Gate source voltage (V)

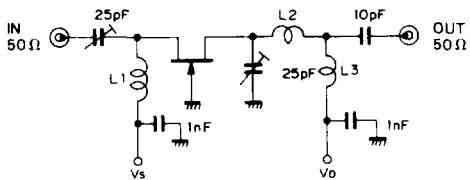


V1, V2 - Input signal level (dBμ)

Block Diagram for IMD Measurement



100 MHz IMD Test Circuit



L1 : 0.45 φmm polyurethane wire 3φ mm 10.5 t
 L2, L3 : 0.45 φmm polyurethane wire 3φ mm 5.5 t

Derating curve

